

212020US99

NEUROS ATES PATENT AND TRADEMARK OFFICE

IN RE APPLICATION OF:

TOMASZ KLOSOWIAK ET AL

SERIAL NO:

09/911,444

GAU:

2826

FILED:

EXAMINER: FORDE

FOR:

JULY 25, 2001 STRUCTURE AND METHOD FOR FABRICATING SEMICONDUCTOR STRUCTURES AND DEVICES WITH OPTICAL PROCESSING LAYERS UTILIZING THE FORMATION OF A COMPLIANT SUBSTRATE FOR

MATERIALS USED TO FORM THE SAME

INFORMATION DISCLOSURE STATEMENT UNDER 37 CFR 1.97

ASSISTANT COMMISSIONER FOR PATENTS WASHINGTON, D.C. 20231

SIR:

Applicant(s) wish to disclose the following information.

REFERENCES

- The applicant(s) wish to make of record the references listed on the attached form PTO-1449. Copies of the listed references were submitted in application Serial No. 09/908,888 according to the attached copy of a Granted Petition. This application contains related subject matter.
- A check is attached in the amount required under 37 CFR §1.17(p).

RELATED CASES

- Attached is a list of applicant's pending application(s) or issued patent(s) which may be related to the present application. A copy of the patent(s), together with a copy of the claims and drawings of the pending application(s) is attached along with PTO 1449.
- A check is attached in the amount required under 37 CFR §1.17(p).

CERTIFICATION

- ☐ Each item of information contained in this information disclosure statement was first cited in a communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this statement.
- ☐ No item of information contained in this information disclosure statement was cited in a communication from a foreign patent office in a counterpart foreign application or, to the knowledge of the undersigned, having made reasonable inquiry, was known to any individual designated in 37 CFR §1.56(c) more than three months prior to the filing of this statement.

DEPOSIT ACCOUNT

Please charge any additional fees for the papers being filed herewith and for which no check is enclosed herewith, or credit any overpayment to deposit account number 15-0030. A duplicate copy of this sheet is enclosed.

Respectfully submitted,

MAIER & YEUSTADT, P.C.

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LIST OF REFERENCES CITED BY APPLICANT

APPLICANT Tomasz KLOSOWIAK, et al.

FILING DATE July 25, 2001 GROUP 2826

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
INITIAL	UT	5,528,209	06/18/96	Macdonald et al.			
	UV	5,998,781	12/07/99	Vawter et al.			
	UW	6,110,813	08/29/00	Ota et al.			
	UX	6,452,232 B1	09/17/02	Adan			
	UY	6,049,110	04/11/00	Koh			
	UZ	5,559,368	09/24/96	Hu et al.			
	VA	6,392,253 B1	05/21/02	Saxena		 	
	VB	5,585,288	12/17/96	Davis et al.			
	VC	5,268,327	12/07/93	Vernon			
	VD	6,198,119 B1	03/06/01	Nabatame et al.			
	VE	6,113,225	09/05/00	Miyata et al.			
	VF	5,262,659	11/16/93	Grudkowski et al.			
	VG	6,239,012 B1	05/29/01	Kinsman			
	VH	6,297,598	10/02/01	Wang et al.		<u> </u>	
<u> </u>	VI	2002/140012	10/03/02	Droopad			
	VJ	4,866,489	09/12/89	Yokogawa et al.			
	VK	6,080,378	06/27/00	Yokota et al.		ļ	
	VL	5,508,554	04/16/96	Takatani et al.			
	VM	6,477,285 B1	11/05/02	Shanley			
	VN	4,695,120	09/22/87	Holder			
	vo	5,882,948	03/16/99	Jewell			
	VP	5,574,589	11/12/96	Feuer et al.			
	VQ	5,510,665	04/23/96	Conley			= =====================================
	VR	4,804,866	02/14/89	Akiyama			100
	vs	5,057,694	10/15/91	Idaka et al.			3
	VT	5,635,453	06/03/97	Pique et al.			
	VU	5,719,417	02/17/98	Roeder et al.			
	T VV	5,998,819	12/07/99	Yokoyama et al.			

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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INITIAL	1001	2002/0079576	06/27/02	Seshan			
	 		09/15/92	Levi et al.			
	 	5,148,504 2002/0195610 A1	12/26/02	Klosowiak			
	 		12/19/95	Matsuda			
	}	5,477,363	05/18/99	Butler et al.			
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	WB	5,570,226	02/11/92	Ishibashi et al.			
	WC	5,087,829	09/06/01	Saito			
	WD	2001/0020278 A1	12/17/02	Uchizaki			
	WE	6,496,469 B1	10/21/97	Doi et al.			
	WF	5,679,947	11/01/01	Kadowaki et al.			
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	WH	5,446,719	11/03/98	Jiang et al.			
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	WL	4,177,094		Makki et al.			6. 6.
	WM_	5,216,359	06/01/93	Nashimoto et al.			5
	WN	6,307,996 B1	10/23/01				
	WO	5,371,621	12/06/94	Stevens Bojarczuk, Jr et al.			3
	WP	2002/0145168 A1	10/10/02	Anderson			-
	WQ	3,617,951	11/02/71			_	
	WR		11/17/98	Bevan et al.			
	ws	5,684,302	11/04/97	Wersing et al.		_	
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	WU		11/08/94				
	WV	5,864,171	01/26/99			-	
	ww	5,028,563	07/02/91				
	WX	5,937,115	08/10/99	Domash		l Considered	

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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
INITIAL	WY	5,878,175	03/02/99	Sonoda et al.			
	WZ	4,801,184	01/31/89	Revelli			
	XA	5,140,387	08/18/92	Okazaki et al.			
<u> </u>	XB	5,410,622	04/25/95	Okada et al.			
<u> </u>	XC	6,064,783	05/16/00	Congdon et al.			
<u> </u>	XD	5,772,758	06/30/98	Collins et al.			
	XE	5,666,376	09/09/97	Cheng			
	XF	5,976,953	11/02/99	Zavracky et al.			
<u>.</u>	XG	5,578,162	11/26/96	D'Asaro et al.			
	ХН	5,585,167	12/17/96	Satoh et al.			
	XI	5,674,813	10/07/97	Nakamura et al.			
	XJ	5,574,296	11/12/96	Park et al.			
	XK	6,504,189	01/07/03	Matsuda et al.			
<u> </u>	XL	5,987,196	11/16/99	Noble			
	XM						
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				TRANS	SLATION
	DOCUMENT NUMBER	DATE	COUNTRY	YES	NO
CBC	EP 1 035 759	09/13/00	Europe		
	EP 0 860 913	08/26/95	EUROPE		
CBE	5-232307	09/10/93	JAPAN W/ENGLISH ABSTRACT		
CBF	5-243525	09/31/93	JAPAN W/ENGLISH ABSTRACT		
	3-171617	07/25/91	JAPAN W/ENGLISH ABSTRACT		
СВН	EP 1 089 338	04/04/01	EUROPE		-
CBI	01 294594	11, 28, 99	JAPAN (ABSTRACT)		+
CBJ	05 221800	08, 31, 43	JAPAN (ABSTRACT)		+
СВК	03-149882	11 07 89	JAPAN		
CBL	0 614 256	09 07 94	EUROPE		-
СВМ	1 054 442	11 22 00	EUROPE		
CBN		07/08/98	EUROPE		-
СВО		01 31 02	WIPO		
CBP		08 16 01	WIPO		
CBQ		10 26 87	JAPAN W/ENGLISH ABSTRACT		-
CBR		06 08 94	EUROPE		
CBS		02 06 91	EUROPE		
CBT		12 15:00	JAPAN (ENGLISH ABSTRACT)		
CBL		08 '08 89	JAPAN (ENGLISH ABSTRACT)		
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